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Information Disclosure Statement Re: 10/698,122

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Commissioner for Patents Alexandria, VA 22313-1450

ATTENTION EXAMINER:

on <u>June 12, 2004</u>
Return phone number 401-885-8032
Fax Phone Number 401-885-1046

Cust. No.: 24,299

Number of Pages including certificate: 3

George Sai-Halasz Agent # 45430

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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In re application of:

Qiqing C. Ouyang et. al.:

Serial No.:

10/698,122

4018851046

Group No.: 2811

Filed:

10/31/2003

Examiner: THOMAS, TOM

For: High Mobility Heterojunction Complementary Field Effect Transistors and Methods

Thereof

Commissioner for Patents Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

The attached form 1449 (Modified) gives references pertaining to the above application.

Respectfully,

George Sai-Halasz Agent # 45430

Customer No.: 24,299

145 Fernwood Drive E. Greenwich, RI 02818. 401-885-8032 (Fax 401-885-1046) E-MAIL - patents@computer.org

06/12/2004

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Form PTO 1449 (modified) LIST OF PRIOR ART CITED BY APPLICANT						Docket No x0R920030327US1			Serial No <u>10/698,122</u>			
						Applicant Olqing C. Ouveng et. al.						
						Filing Date 10/31/2003		G	Group 2811			
				U. S. PATI	ENT	DOCUMENTS						
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